

## **General Description**

The WSD4018DN22 is the highest performance trench P-ch MOSFETs with extreme high cell density, which provide excellent RDSON and gate charge for most of the small power switching and load switch applications.

The WSD4018DN22 meet the RoHS and Green Product requirement with full function reliability approved.

#### **Features**

- Advanced high cell density Trench technology
- Super Low Gate Charge
- Excellent Cdv/dt effect decline
- Green Device Available

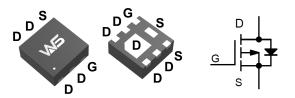
## **Product Summery**

BVDSS	RDSON	SON ID	
-40V	26mΩ	-18A	

## **Applications**

- High Frequency Point-of-Load Synchronous
  Small power switching for MB/NB/UMPC/VGA
- Networking DC-DC Power System
- Load Switch

## **DFN2X2-6L Pin Configuration**



# **Absolute Maximum Ratings**

Symbol	Parameter Rating		Units
V <sub>DS</sub>	Drain-Source Voltage -40		V
$V_{GS}$	Gate-Source Voltage	Gate-Source Voltage ±20	
I <sub>D</sub> @T <sub>c</sub> =25℃	25℃ Continuous Drain Current, V <sub>GS</sub> @ -10V <sup>1</sup> -18		А
I <sub>D</sub> @T <sub>c</sub> =70℃	Continuous Drain Current, V <sub>GS</sub> @ -10V <sup>1</sup>		
I <sub>DM</sub>	300μS Pulsed Drain Current,V <sub>GS</sub> =-4.5V <sup>2</sup>		
P <sub>D</sub> @T <sub>c</sub> =25°C	Total Power Dissipation <sup>3</sup>		
T <sub>STG</sub>	Storage Temperature Range		
T <sub>J</sub>	T <sub>J</sub> Operating Junction Temperature Range -55 to 150		$^{\circ}$

### **Thermal Data**

Symbol	Parameter	Parameter Typ. Max.		Unit
$R_{ heta JA}$	Thermal Resistance Junction-ambient <sup>1</sup>		36	°C/W
R <sub>eJC</sub>	Thermal Resistance Junction-Case <sup>1</sup>		6.5	°C/W



P-Ch MOSFET

# Electrical Characteristics (T<sub>J</sub>=25 °C, unless otherwise noted)

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	$V_{GS}$ =0V , $I_D$ =-250uA	-40			V
$\triangle BV_{DSS}/\triangle T_{J}$	BVDSS Temperature Coefficient	Reference to 25℃, I <sub>D</sub> =-1mA		-0.01		V/℃
D	Static Drain-Source On-Resistance <sup>2</sup>	V <sub>GS</sub> =-10V , I <sub>D</sub> =-8.0A		26	34	mΩ
R <sub>DS(ON)</sub>	Static Drain-Source On-Resistance	V <sub>GS</sub> =-4.5V , I <sub>D</sub> =-6.0A		31	42	
$V_{GS(th)}$	Gate Threshold Voltage	\\ -\\   - 2500A	-1.0	-1.5	-3.0	٧
$\triangle V_{GS(th)}$	V <sub>GS(th)</sub> Temperature Coefficient	$V_{GS}=V_{DS}$ , $I_D=-250uA$		3.13		mV/℃
	Drain Source Leakage Current	V <sub>DS</sub> =-40V , V <sub>GS</sub> =0V , T <sub>J</sub> =25°C V <sub>DS</sub> =-40V , V <sub>GS</sub> =0V , T <sub>J</sub> =55°C			-1	-1 -5 uA
I <sub>DSS</sub>	Drain-Source Leakage Current				-5	
I <sub>GSS</sub>	Gate-Source Leakage Current	$V_{GS}$ = $\pm 20 V$ , $V_{DS}$ = $0 V$			±100	nA
Qg	Total Gate Charge (-4.5V)			27		
$Q_{gs}$	Gate-Source Charge	V <sub>DS</sub> =-20V , V <sub>GS</sub> =-10V , I <sub>D</sub> =-1.5A		2.5		nC
Q <sub>gd</sub>	Gate-Drain Charge			6.7		
T <sub>d(on)</sub>	Turn-On Delay Time			9.8		
Tr	Rise Time	V <sub>DD</sub> =-20V , V <sub>GS</sub> =-10V ,		11		
T <sub>d(off)</sub>	Turn-Off Delay Time	$R_G=3\Omega$ , $R_L=10\Omega$		54		ns
T <sub>f</sub>	Fall Time			7.1		
C <sub>iss</sub>	Input Capacitance			1560		
Coss	Output Capacitance	V <sub>DS</sub> =-20V , V <sub>GS</sub> =0V , f=1MHz		116		pF
C <sub>rss</sub>	Reverse Transfer Capacitance			97		

## **Diode Characteristics**

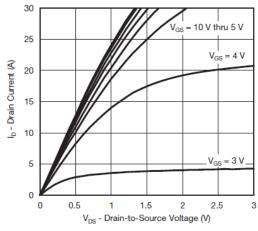
Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
Is	Continuous Source Current <sup>1,4</sup>	V <sub>G</sub> =V <sub>D</sub> =0V , Force Current			-18	Α
$V_{SD}$	Diode Forward Voltage <sup>2</sup>	V <sub>GS</sub> =0V , I <sub>S</sub> =-1A , T <sub>J</sub> =25℃			-1.2	V

#### Note:

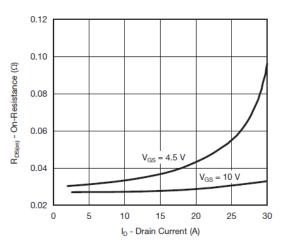
- 1.The data tested by surface mounted on a 1 inch² FR-4 board with 2OZ copper, t≦10sec.
- 2.The data tested by pulsed , pulse width  $\,\leq\,$  300us , duty cycle  $\,\leq\,$  2%
- 4. The data is theoretically the same as  $I_D$  and  $I_{DM}$ , in real applications, should be limited by total power dissipation.



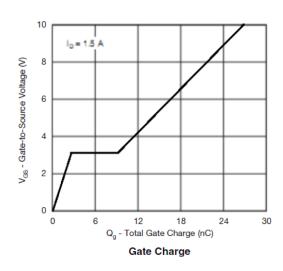
# Typical Performance Characteristics ((TJ = 25 ℃, unless otherwise noted))

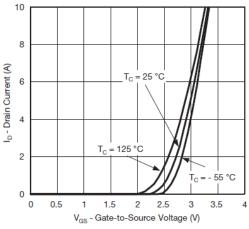


#### **Output Characteristics**

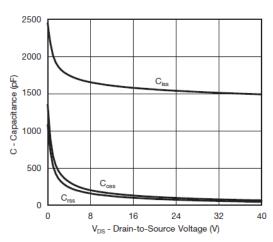


On-Resistance vs. Drain Current and Gate Voltage

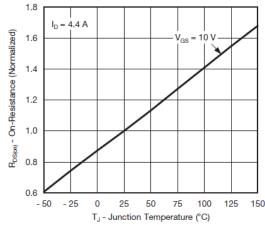




**Transfer Characteristics** 

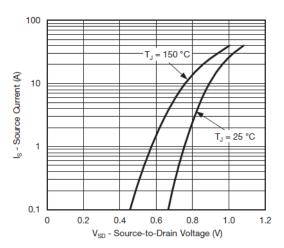


Capacitance

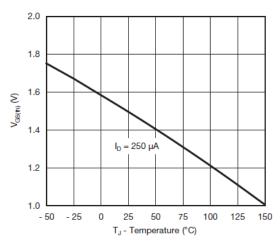


On-Resistance vs. Junction Temperature

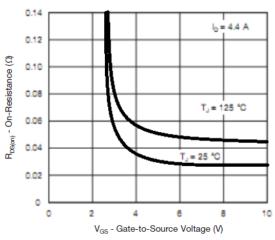




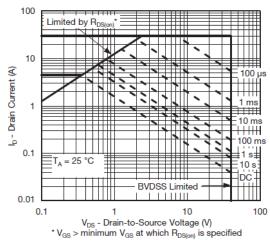
Soure-Drain Diode Forward Voltage



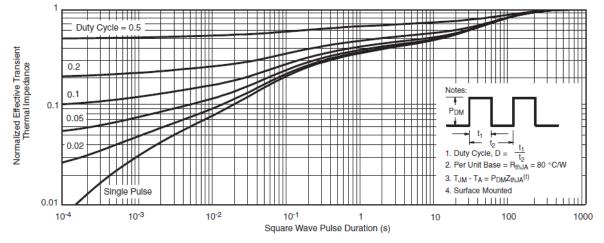
Threshold Voltage



On-Resistance vs. Gate-to-Source Voltage

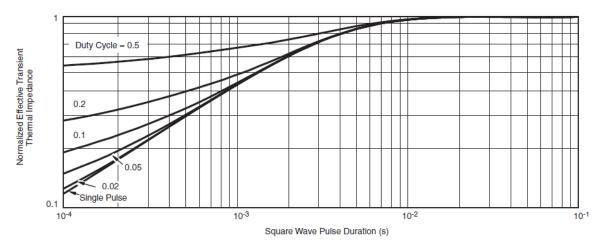


Safe Operating Area, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Ambient





Normalized Thermal Transient Impedance, Junction-to-Case



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